

<b>Notice of References Cited</b>	Application/Control No. 10/797,579	Applicant(s)/Patent Under Reexamination LEE ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0072525	04-2005	Pancham et al.	156/345.11
*	B	US-2003/0070695	04-2003	Emami et al.	134/33
	C	US-			
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**FOREIGN PATENT DOCUMENTS**

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